

**Search Notes**

Application/Control No.

10/672,943

Examiner

Yicun Wu

Applicant(s)/Patent under  
Reexamination

NUNEZ, CHRIS

Art Unit

2165

**SEARCHED**

Class	Subclass	Date	Examiner
707	1-10, 100-104.1 200-206	6/6/2006	YW
715,	515-517	6/6/2006	YW
715	501	6/6/2006	YW
711	137	6/6/2006	YW
Updated Search		3/28/07	Y

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search (double patenting) uspto uspgpub epo jpo ibmtech derwent	6/6/2006	YW
acm ieee citeseer internet Search strategy attached	6/6/2006	YW
updated Search consulted Pat Sales	3/28/07	Y